



Galvanically isolated 4 A single gate driver for SiC MOSFETs



Features

- High voltage rail up to 1200 V
- Driver current capability: 4 A sink/source @25°C
- dV/dt transient immunity ±100 V/ns in full temperature range
- Overall input-output propagation delay: 75 ns
- · Separate sink and source option for easy gate driving configuration
- 4 A Miller CLAMP dedicated pin option
- UVLO function
- Gate driving voltage up to 26 V
- 3.3 V, 5 V TTL/CMOS inputs with hysteresis
- · Temperature shut-down protection
- · Standby function
- 6 kV galvanic isolation
- · Wide body SO-8W package

Description

The STGAP2SICS is a single gate driver which provides galvanic isolation between the gate driving channel and the low voltage control and interface circuitry.

The gate driver is characterized by 4 A capability and rail-to-rail outputs, making the device also suitable for mid and high power applications such as power conversion and motor driver inverters in industrial applications. The device is available in two different configurations. The configuration with separated output pins allows to independently optimize turn-on and turn-off by using dedicated gate resistors. The configuration featuring single output pin and Miller CLAMP function prevents gate spikes during fast commutations in half-bridge topologies. Both configurations provide high flexibility and bill of material reduction for external components.

The device integrates protection functions: UVLO with optimized value for SiC MOSFETs and thermal shut down are included to facilitate the design of highly reliable systems. Dual input pins allow the selection of signal polarity control and implementation of HW interlocking protection to avoid cross-conduction in case of controller malfunction. The input to output propagation delay is less than 75 ns, which delivers high PWM control accuracy. A standby mode is available to reduce idle power consumption.





1 Block diagram

Figure 1. Block diagram - Single output and Miller Clamp configuration

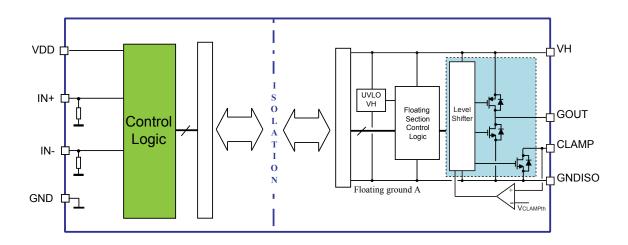
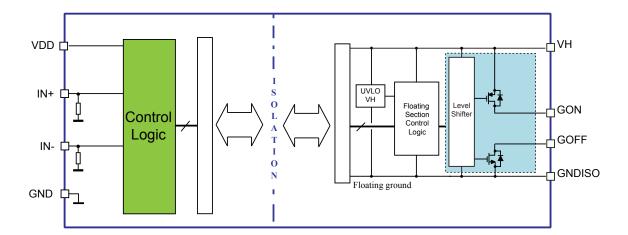


Figure 2. Block diagram - Separate output configuration



DS13402 - Rev 3 page 2/23



2 Pin description and connection diagram

Figure 3. Pin connection (top view) - Single output and Miller CLAMP option

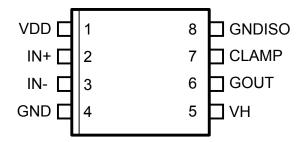


Figure 4. Pin connection (top view) - Separated outputs option

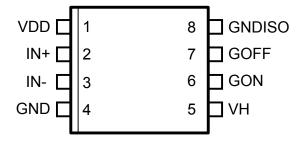


Table 1. Pin Description

Pir	1#	Pin Name Type Func		Function
Figure 4	Figure 3	Fill Name	Туре	Function
1	1	VDD	Power Supply	Driver logic supply voltage.
2	2	IN+	Logic Input	Driver logic input, active high.
3	3	IN-	Logic Input	Driver logic input, active low.
4	4	GND	Power Supply	Driver logic ground.
5	5	VH	Power Supply	Gate driving positive voltage supply.
-	6	GOUT	Analog Output	Sink/Source output.
-	7	CLAMP	Analog Output	Active Miller Clamp.
6	-	GON	Analog Output	Source output.
7	-	GOFF	Analog Output	Sink output.
8	8	GNDISO	Power Supply	Gate driving Isolated ground.

DS13402 - Rev 3 page 3/23



3 Electrical data

3.1 Absolute maximum ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Test condition	Min.	Max.	Unit
VDD	Logic supply voltage vs. GND	-	-0.3	6.5	V
V _{LOGIC}	Logic pins voltage vs. GND	-	-0.3	6.5	V
VH	Positive supply voltage (VH vs. GNDISO)	-	-0.3	28	V
V _{OUT}	Voltage on gate driver outputs (GON, GOFF, CLAMP VS. GNDISO)	-	-0.3	VH+0.3	V
TJ	Junction temperature	-	-40	150	°C
T _S	Storage temperature	-	-50	150	°C
ESD	HBM (human body model)	-		2	kV

3.2 Thermal data

Table 3. Thermal data

Symbol	Parameter	Package	Value	Unit
$R_{\text{th(JA)}}$	Thermal resistance junction to ambient	SO-8W	120	°C/W

3.3 Recommended operating conditions

Table 4. Recommended operating conditions

Symbol	Parameter	Test conditions	Min.	Max.	Unit
VDD	Logic supply voltage vs. GND	-	3.1	5.5	V
V _{LOGIC}	Logic pins voltage vs. GND	-	0	5.5	V
VH	Positive supply voltage (VH vs. GNDISO)	-	Max(VH _{ON})	26	V
F _{SW}	Maximum switching frequency ⁽¹⁾	-	-	1	MHz
tout	Output pulse width (GOUT, GON-GOFF)	-	100	-	ns
TJ	Operating Junction Temperature	-	-40	125	°C

^{1.} Actual limit depends on power dissipation and T_J .

DS13402 - Rev 3 page 4/23



4 Electrical characteristics

Table 5. Electrical characteristics ($T_J = 25$ °C, VH = 18 V, VDD = 5 V unless otherwise specified)

Pin	Parameter	Test conditions	Min.	Тур.	Max.	Unit
haracteristic	cs					
IN+, IN-	Input to output propagation delay ON	-	50	75	90	ns
IN+, IN-	Input to output propagation delay OFF	-	50	75	90	ns
-	Rise time	CL = 4.7 nF	-	30	-	ns
-	Fall time	See Figure 12	-	30	-	ns
-	Pulse Width Distortion t _{Don} -t _{Doff}	-	-	-	20	ns
IN+, IN-	Inputs deglitch filter	-	-	20	40	ns
-	Common-mode transient immunity, dVISO/dt	VCM = 1500 V, See Figure 13	100	-	-	V/ns
tage				,	,	
-	VH UVLO turn-on threshold	-	14.6	15.5	16.4	V
-	VH UVLO turn-off threshold	-	13.9	14.8	15.7	V
-	VH UVLO hysteresis	-	600	750	950	mV
-	VH undervoltage quiescent supply current	VH = 7V	-	1.3	1.8	mA
-	VH quiescent supply current	-	-	1.3	1.8	mA
-	Standby VH quiescent supply current	Standby mode	-	400	550	μA
-	GOFF active clamp	I _{GOFF} = 0.2 A; VH floating	-	2	2.3	V
-	VDD quiescent supply current	-	-	1.0	1.3	mA
-	Standby VDD quiescent supply current	Standby mode	-	40	65	μA
ts						
IN+, IN-	Low level logic threshold voltage	-	0.29·VDD	0.33·VDD	0.37·VDD	V
IN+, IN-	High level logic threshold voltage	-	0.62·VDD	0.66·VDD	0.70·VDD	V
IN+, IN-	INx logic "1" input bias current	IN _x = 5 V	33	50	70	μA
IN+, IN-	INx logic "0" input bias current	IN _x = GND	-	-	1	μA
IN+, IN-	Inputs pull-down resistors	IN _x = 5 V	70	100	150	kΩ
er section						
		T _J = 25°C	-	4	-	Α
-	Source short circuit current	T _J = -40 to +125°C	3	-	5	Α
-	Source output high level voltage	I _{GON} = 100 mA	VH-0.15	VH-0.125	-	V
	haracteristic IN+, IN- IN+, IN- IN+, IN- - - - - - - - - - - - - - - - - - IN+, IN- IN+,	IN+, IN- Input to output propagation delay ON IN+, IN- Input to output propagation delay OFF - Rise time - Fall time - Pulse Width Distortion ItDon-tDoff Inputs deglitch filter - Common-mode transient immunity, IdVISO/dt Inmunity, IdVISO/dt	In In In In In In In In	Input to output propagation delay ON	In In In In In In In In	Input to output propagation delay ON

DS13402 - Rev 3 page 5/23



Symbol	Pin	Parameter	Test conditions	Min.	Тур.	Max.	Unit
R _{GON}	-	Source R _{DS_ON}	I _{GON} = 100 mA	-	1.25	1.5	Ω
			T _J = 25°C	-	4	-	
I _{GOFF}	-	Sink short-circuit current	$T_{J} = -40 \text{ to } +125^{\circ}\text{C}$	3	-	5.5	А
V _{GOFFL}	-	Sink output low level voltage	I _{GOFF} = 100 mA	-	100	120	mV
R _{GOFF}	-	Sink R _{DS_ON}	I _{GOFF} = 100 mA	-	1.0	1.2	Ω
Miller Clam	p						
V _{CLAMPth}	-	CLAMP voltage threshold	V _{CLAMP} vs.GNDISO	1.3	2	2.6	V
			V _{CLAMP} = 15V				
I _{CLAMP}	_	CLAMP short-circuit current	T _J = 25°C	-	4	-	A
			$T_{J} = -40 \text{ to } +125^{\circ}\text{C}$	2	-	5	
V _{CLAMP_L}	-	CLAMP low level output voltage	I _{CLAMP} = 100mA	-	96	115	mV
R _{CLAMP}	-	CLAMP R _{DS_ON}	I _{CLAMP} = 100mA	-	0.96	1.15	Ω
Over-tempe	rature pro	tection				1	
T _{SD}	-	Shutdown temperature	-	170	-	-	°C
T _{hys}	-	Temperature hysteresis	-	-	20	-	°C
Standby		<u>'</u>			1	'	
t _{STBY}	-	Standby time	See Control inputs	200	280	500	μs
t _{WUP}	-	Wake-up time	See Control inputs	10	20	35	μs
t _{awake}	-	Wake-up delay	See Control inputs	90	140	200	μs
t _{stbyfilt}	-	Standby filter	See Control inputs	200	280	800	ns

^{1.} Characterization data, not tested in production.

DS13402 - Rev 3 page 6/23





5 Isolation

Table 6. Isolation and safety-related specifications

Parameter	Symbol	Value	Unit	Conditions
Clearance (Minimum External Air Gap)	CLR	8	mm	Measured from input terminals to output terminals, shortest distance through air
Creepage (*) (Minimum External Tracking)	CPG	8	mm	Measured from input terminals to output terminals, shortest distance path along body
Comparative Tracking Index (Tracking Resistance)	СТІ	≥ 400	V	DIN IEC 112/VDE 0303 Part 1
Isolation Group	-	II	-	Material Group (DIN VDE 0110, 1/89, Table 1)

Table 7. Isolation characteristics

Parameter	Symbol	Test Conditions	Characteristic	Unit
Maximum Working Isolation Voltage	V _{IORM}	-	1200	V _{PEAK}
		Method a, Type test		
		$V_{PR} = V_{IORM} \times 1.6$, $t_m = 10 \text{ s}$	1920	V _{PEAK}
Input to Output test voltage	V _{PR}	Partial discharge < 5 pC		
In accordance with VDE 0884-11	V PR	Method b1, 100 % Production test		
		$V_{PR} = V_{IORM} \times 1.875, t_m = 1 s$	2250	
		Partial discharge < 5 pC		
Transient Overvoltage (Highest Allowable Overvoltage)	V _{IOTM}	t _{ini} = 60 s Type test	6000	V _{PEAK}
Maximum Surge TestVoltage	V _{IOSM}	Type test	6000	V _{PEAK}
Isolation Resistance	R _{IO}	V _{IO} = 500 V; Type test	>10 ⁹	Ω

Table 8. Isolation voltage as per UL 1577

Parameter	Symbol	Characteristic	Unit
Isolation Withstand Voltage, 1min (Type test)	V _{ISO}	3535/5000	V _{RMS} /V _{PEAK}
Isolation TestVoltage, 1sec (100% production)	V _{ISOtest}	4242/6000	V _{RMS} /V _{PEAK}

DS13402 - Rev 3 page 7/23

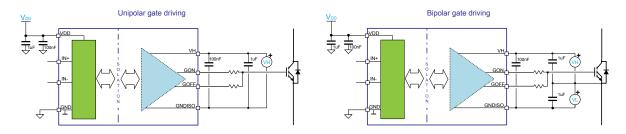


6 Functional description

6.1 Gate driving power supply and UVLO

The STGAP2SiCS is a flexible and compact gate driver with 4 A output current and rail-to-rail outputs. The device allows implementation of either unipolar or bipolar gate driving.

Figure 5. Power supply configuration for unipolar and bipolar gate driving



Undervoltage protection is available on VH supply pin. A fixed hysteresis sets the turn-off threshold, thus avoiding intermittent operation.

When VH voltage falls below the VHoff threshold, the output buffer enters a "safe state". When VH voltage reaches the VHon threshold, the device returns to normal operation and sets the output according to actual input pins status.

The VDD and VH supply pins must be properly filtered with local bypass capacitors. The use of capacitors with different values in parallel provides both local storage for impulsive current supply and high-frequency filtering. The best filtering is obtained by using low-ESR SMT ceramic capacitors and are therefore recommended. A 100 nF ceramic capacitor must be placed as close as possible to each supply pin, and a second bypass capacitor with value in the range between 1 μ F and 10 μ F should be placed close to it.

6.2 Power-up, power-down and "safe state"

The following conditions define the "safe state":

- GOFF = ON state;
- GON = High Impedance;
- CLAMP = ON state (for STGAP2SiCSC);

Such conditions are maintained at power-up of the isolated side (VH < VH_{on}) and during whole device power down phase (VH < VH_{off}), regardless of the value of the input pins.

The device integrates a structure which clamps the driver output to a voltage not higher than SafeClp when VH voltage is not high enough to actively turn the internal GOFF MOSFET on. If VH positive supply pin is floating or not supplied the GOFF pin is therefore clamped to a voltage smaller than SafeClp.

If the supply voltage VDD of the control section of the device is not supplied, the output is put in safe state, and remains in such condition until the VDD voltage returns within operative conditions.

After power-up of both isolated and low voltage sides, the device output state depends on the status of the input pins.

DS13402 - Rev 3 page 8/23



6.3 Control inputs

The device is controlled through the IN+ and IN- logic inputs, in accordance with the truth table below.

Table 9. Inputs truth table (applicable when device is not in UVLO or "safe state")

Inpu	t pins	Output pins		
IN+	IN-	GON	GOFF	
L	L	OFF	ON	
Н	L	ON	OFF	
L	Н	OFF	ON	
Н	Н	OFF	ON	

A deglitch filter allows input signals with duration shorter than tdeglitch to be ignored, thereby preventing noise spikes potentially present in the application from generating unwanted commutations.

6.4 Miller Clamp function

The Miller clamp function allows the control of the Miller current during the power stage switching in half-bridge configurations. When the external power transistor is in the OFF state, the driver operates to avoid the induced turn-on phenomenon that may occur when the other switch in the same leg is being turned on, due to the C_{GD} capacitance.

During the turn-off period the gate of the external switch is monitored through the CLAMP pin. The CLAMP switch is activated when gate voltage goes below the voltage threshold, V_{CLAMPth}, thus creating a low impedance path between the switch gate and the GNDISO pin.

6.5 Watchdog

The isolated HV side has a watchdog function in order to identify when it is not able to communicate with LV side, for example because the VDD of the LV side is not supplied. In this case the output of the driver is forced in "safe state" until communication link is properly established again.

6.6 Thermal shutdown protection

The device provides a thermal shutdown protection. When junction temperature reaches the T_{SD} temperature threshold, the device is forced in "safe state". The device operation is restored as soon as the junction temperature is lower than T_{SD} - T_{hys} .

DS13402 - Rev 3 page 9/23



6.7 Standby function

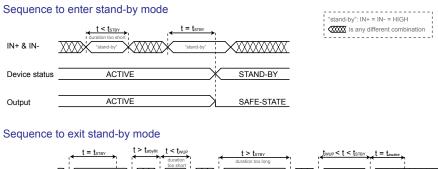
In order to reduce the power consumption of both control interface and gate driving sides the device can be put in standby mode. In standby mode the quiescent current from VDD and VH supply pins is reduced to I_{QDDSBY} and I_{QHSBY} respectively, and the output remains in "safe state" (the output is actively forced low).

The way to enter standby is to keep both IN+ and IN- high ("standby" value) for a time longer than t_{STBY}. During stand-by the inputs can change from the "standby" value.

To exit stand-by, IN+ and IN- must be put in any combination different from the "standby" value for a time longer than $t_{stbyfilt}$, and then in the "standby" value for a time t such that t_{WUP} <t < $t_{stbyfilt}$.

When the input configuration is changed from the "standby" value the output is enabled and set according to inputs state after a time t_{awake} .

Figure 6. Standby state sequences



IN+ & IN
Device status

ACTIVE

ACTIVE

SAFE-STATE

Lower t < tsrey

duration

to long

duration too long

duration too long

stand-by

stand-by

stand-by

STAND-BY

ACTIVE

ACTIVE

ACTIVE

DS13402 - Rev 3 page 10/23



7 Typical application diagram

Figure 7. Typical application diagram - Separated outputs

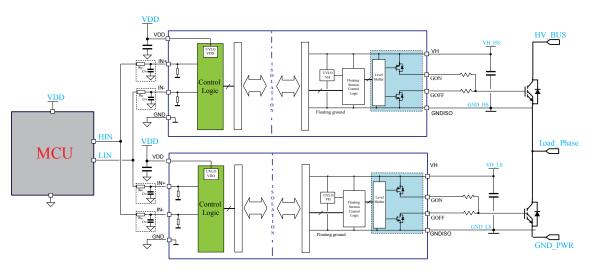
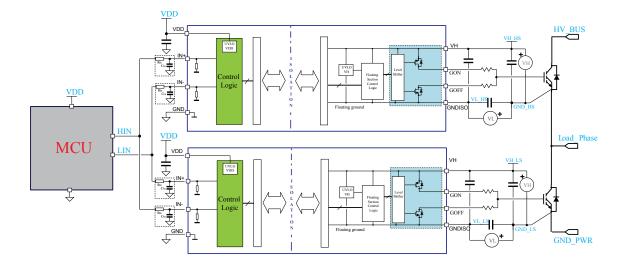


Figure 8. Typical application diagram - Separated outputs and negative gate driving



DS13402 - Rev 3 page 11/23



VDD

VDD

VDD

VDD

VDD

A

Floating ground A

VH

Floating ground A

VH

VBUS

VH

Floating ground A

VH

VBUS

VH

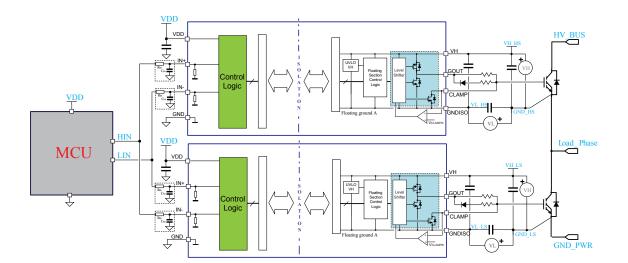
VBUS

VII IS

VII

Figure 9. Typical application diagram - Miller Clamp

Figure 10. Typical application diagram - Miller Clamp and negative gate driving



DS13402 - Rev 3 page 12/23



8 Layout

8.1 Layout guidelines and considerations

In order to optimize the PCB layout, the following considerations should be taken into account:

- SMT ceramic capacitors (or different types of low-ESR and low-ESL capacitors) must be placed close to each supply rail pins. A 100 nF capacitor must be placed between VDD and GND and between VH and GNDISO, as close as possible to device pins, in order to filter high-frequency noise and spikes. In order to provide local storage for pulsed current, a second capacitor with a value between 1 μ F and 10 μ F should also be placed close to the supply pins.
- It is good practice to add filtering capacitors close to logic inputs of the device (IN+, IN-), particularly for fast switching or noisy applications.
- The power transistors must be placed as close as possible to the gate driver to minimize the gate loop area and inductance that might carry noise or cause ringing.
- To avoid degradation of the isolation between the primary and secondary side of the driver, there should not be any trace or conductive area below the driver.
- If the system has multiple layers, it is recommended to connect the VH and GNDISO pins to internal ground or power planes through multiple vias of adequate size. These vias should be located close to the IC pins to maximize thermal conductivity.

8.2 Layout example

An example of STGAP2SiCSC half-bridge suggested PCB layout with main signals highlighted by different colors is shown in Figure 11. It is recommended to follow this example for correct positioning and connection of filtering capacitors.

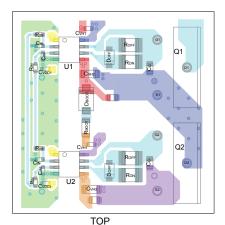


Figure 11. Half-bridge suggested PCB layout





9 Testing and characterization information

Figure 12. Timings definition

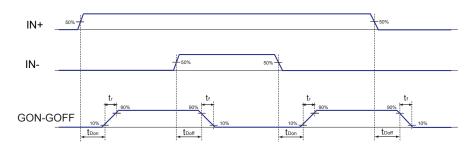
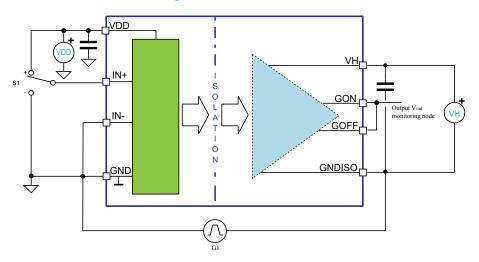


Figure 13. CMTI test circuit



DS13402 - Rev 3 page 14/23



10 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

DS13402 - Rev 3 page 15/23



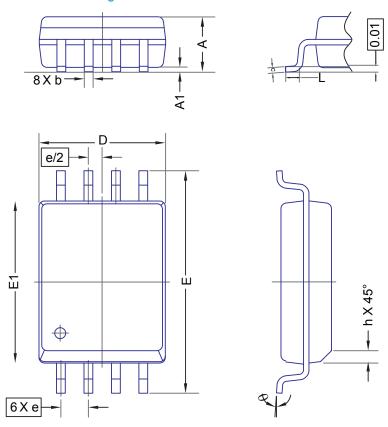
10.1 SO-8W package information

Table 10. SO-8W package dimensions

Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15mm per side.

Symbol	Dimensions (mm)				
Зушрог	Min.	Тур.	Max		
Α	2.34		2.64		
A1	0.1		0.3		
b	0.3		0.51		
С	0.2		0.33		
D	5.64		6.05		
е		1.27 BSC			
E1	7.39		7.59		
E	10.11		10.52		
L	0.61		0.91		
h	0.25		0.76		
Θ	0°		8°		
aaa	0.25				
bbb	0.25				
ccc		0.1			

Figure 14. SO-8W mechanical data

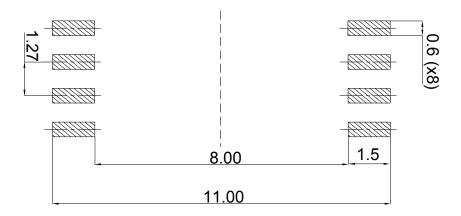


DS13402 - Rev 3 page 16/23



10.2 SO-8W suggested land pattern

Figure 15. SO-8W suggested land pattern



DS13402 - Rev 3 page 17/23



11 Ordering information

Table 11. Device summary

Order code	Output configuration	Package marking	Package	Packaging
STGAP2SICSTR	GON-GOFF	GAP2IS	SO-8W	Tape and Reel
STGAP2SICSCTR	GOUT-CLAMP	GAP2SIC	SO-8W	Tape and Reel

DS13402 - Rev 3 page 18/23



Revision history

Table 12. Document revision history

Date	Version	Changes
10-Sep-2020	1	Initial release.
13-Aug-2021	2	Update VDD parameter in Table 4; update Isolation Resistance Test condition parameter in Table 7; update title of Table 8; change Figure 15 and Figure 10; updated Table 3; updated Driver buffer section and Standby in Table 5.
15-Oct-2021	3	Updated test condition in Table 5

DS13402 - Rev 3 page 19/23



Contents

1	Bloc	k diagram	.2
2	Pin d	lescription and connection diagram	.3
3	Elect	rical data	.4
	3.1	Absolute maximum ratings	. 4
	3.2	Thermal data	. 4
	3.3	Recommended operating conditions	. 4
4	Elect	rical characteristics	. 5
5	Isola	tion	.7
6	Func	tional description	.8
	6.1	Gate driving power supply and UVLO	. 8
	6.2	Power-up, power-down and "safe state"	. 8
	6.3	Control inputs	. 9
	6.4	Miller Clamp function	. 9
	6.5	Watchdog	. 9
	6.6	Thermal shutdown protection	. 9
	6.7	Standby function	10
7	Typic	cal application diagram	11
8	Layo	ut	13
	8.1	Layout guidelines and considerations	13
	8.2	Layout example	13
9	Testi	ng and characterization information	14
10	Pack	age information	15
	10.1	SO-8W package information	16
	10.2	SO-8W suggested land pattern	17
11	Orde	ring information	18
Rev	ision l	nistory	19
Con	tents		20
List	of tab	iles	21
List	of fig	ures	22





List of tables

Table 1.	Pin Description
Table 2.	Absolute maximum ratings
Table 3.	Thermal data4
Table 4.	Recommended operating conditions
Table 5.	Electrical characteristics (T _J = 25°C, VH = 18 V, VDD = 5 V unless otherwise specified)
Table 6.	Isolation and safety-related specifications
Table 7.	Isolation characteristics
Table 8.	Isolation voltage as per UL 1577
Table 9.	Inputs truth table (applicable when device is not in UVLO or "safe state")
Table 10.	SO-8W package dimensions
Table 11.	Device summary
Table 12.	Document revision history

DS13402 - Rev 3 page 21/23





List of figures

Figure 1.	Block diagram - Single output and Miller Clamp configuration	2
Figure 2.	Block diagram - Separate output configuration	2
Figure 3.	Pin connection (top view) - Single output and Miller CLAMP option	3
Figure 4.	Pin connection (top view) - Separated outputs option	3
Figure 5.	Power supply configuration for unipolar and bipolar gate driving	8
Figure 6.	Standby state sequences	10
Figure 7.	Typical application diagram - Separated outputs	11
Figure 8.	Typical application diagram - Separated outputs and negative gate driving	11
Figure 9.	Typical application diagram - Miller Clamp	12
Figure 10.	Typical application diagram - Miller Clamp and negative gate driving	12
Figure 11.	Half-bridge suggested PCB layout	13
Figure 12.	Timings definition	14
Figure 13.	CMTI test circuit	
Figure 14.	SO-8W mechanical data	16
Figure 15.	SO-8W suggested land pattern	17

DS13402 - Rev 3 page 22/23



IMPORTANT NOTICE - PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. For additional information about ST trademarks, please refer to www.st.com/trademarks. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2021 STMicroelectronics - All rights reserved

DS13402 - Rev 3 page 23/23

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Gate Drivers category:

Click to view products by STMicroelectronics manufacturer:

Other Similar products are found below:

00053P0231 56956 57.404.7355.5 LT4936 57.904.0755.0 5882900001 00600P0005 00-9050-LRPP 00-9090-RDPP 5951900000 011003W-10/32-15 0131700000 00-2240 LTP70N06 LVP640 5J0-1000LG-SIL LY1D-2-5S-AC120 LY2-US-AC240 LY3-UA-DC24
00576P0020 00600P0010 LZN4-UA-DC12 LZNQ2M-US-DC5 LZNQ2-US-DC12 LZP40N10 00-8196-RDPP 00-8274-RDPP 00-8275RDNP 00-8722-RDPP 00-8728-WHPP 00-8869-RDPP 00-9051-RDPP 00-9091-LRPP 00-9291-RDPP 0207100000 0207400000 01312
0134220000 60713816 M15730061 61161-90 61278-0020 6131-204-23149P 6131-205-17149P 6131-209-15149P 6131-218-17149P 6131220-21149P 6131-260-2358P 6131-265-11149P CS1HCPU63